Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/621,077	OHNISHI ET AL.
Examiner	Art Unit
Dinh Q. Nguyen	3752

SEARCHED					
Class	Subclass	Date	Examiner		
					
239	102.1		!		
		1-10-05	WN		
128	200.14				
	200.16				
	200.18	1-10-05	WU		
347	47				
	54				
1	68				
	69	***************************************			
	70	1-10-05	60		
123	498	1-10-05	08N		
251	129.06	1-10-05			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
239	102.2				
	102.1	1-10-05	00		
251	129.06	1-10-05	W U		
123	498	1-1005	WN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
HAST SEARCH ATTACHED				
	1-10-05	1000		